
PRACTICAL ASPECTS OF QUANTIZATION AND TAMPER- SENSITIVITY FOR POKS

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AGENDA

- Introduction
- Related Work
- Quantization for POKs
- Case Study
- Conclusion

Introduction

- Physical Unclonable Functions (PUFs) based on manufacturing variations
- Variations must be hard to predict and easy to evaluate
- Applications of PUFs in general:
 - Key storage
 - PUFs *not* being tamper-evident, e.g. SRAM-PUF
 - PUFs being tamper-evident, e.g. Coating-PUF ← *focus of this work*
 - Challenge-Response authentication
- Tamper-evident PUFs often named „Physically Obfuscated Key“ (POK)
- Physical attacks (tampering)
 - Drilling, cutting, removal → likely to change POK („tamper-evident“)
 - Probing attempts → improbable to read POK („read-proof“)

Introduction

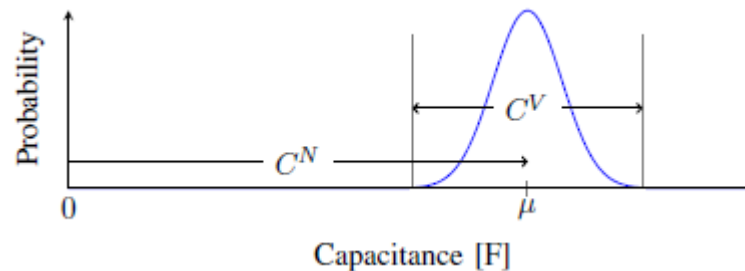
- Certain standards (e.g. FIPS 140-2 Level 4) mandate protection mechanisms to achieve physical security of a certified device
 - Board-level protection, i.e., PCB and its components
 - IC-level protection, i.e., integrated circuit and its package
- Standards require tamper-detection and response mechanism
 - Attacks shall be detected by protected device
 - Response shall protect sensitive data, e.g., by means of zeroization
- POKs as ideal candidate for protected key storage
 - POK as „Key-Encryption-Key“ → other keys of the system and its main software depend on derived key of the POK („tamper-proof“ data)
 - Physical attack destroys POK → encrypted data cannot be recovered

Introduction

- Using a POK requires a process to generate a key
 - Measurement of variation (e.g., analog-to-digital conversion via ADC)
 - Quantization-scheme of raw measurement data ← *focus of this work*
 - Additional post-processing
- From a cryptographic point of view, the generated *key* shall be
 - Unique for each device and uniformly distributed
 - Reliable such that each generation attempt yields the same key
- *Quantization* can be optimized towards
 - Key quality (uniqueness, equi-probability of bits)
 - Reliability (likelihood of obtaining the same key each time)
 - Tamper-sensitivity (sensitivity towards attacks) ← *important!*

Tamper-Sensitivity?

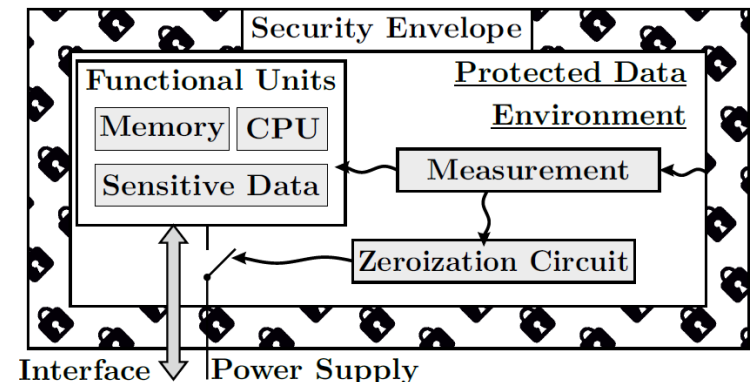
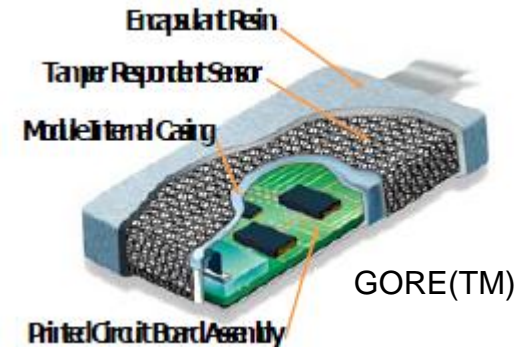
- Example: POK consists of multiple capacitances, each is composed of:
 - Nominal capacitance: C^N
 - Variation due to manufacturing: C^V (relevant for POK values)
- What is the smallest shift (caused by an attack) for a single capacitance that goes undetected?
 - Different compared to noise / can it be distinguished from noise?
 - Magnitude of detectable shift depends on resolution of measurement circuit, present noise, and post-processing (i.e., quantization, and ECC)



RELATED WORK

What We Do

- Prior work: Devices protected with printed mesh on a flexible substrate
 - Mesh is continuously monitored to detect penetration attempts
 - Monitoring initialized at factory-site and *battery-backed* (active throughout lifetime of device)
- Our work: Use flexible substrate with electrodes as a POK
 - Does *not* require battery
 - *Key generation* to decrypt software of the device / determine integrity
 - Attack=physical destruction of key

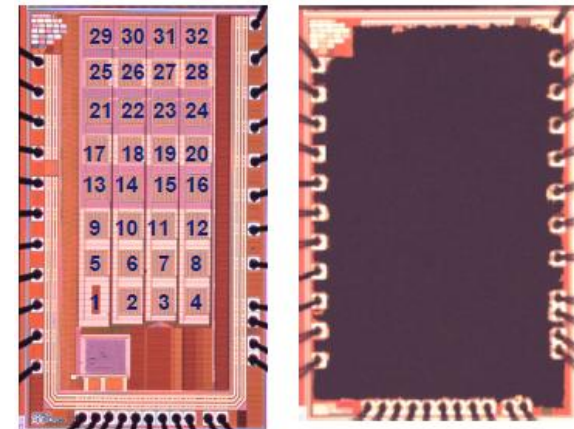


Related Work

- Key generation for PUFs/POKs typically divided in two stages:
 - Key enrollment: key is derived for the first time, *helper data* is generated to support later key reconstruction
 - Key reconstruction: subsequent use of system results in *noisy* values which can be stabilized using the helper data
- Helper data may cause information leakage, i.e., leaks information about the actual key being derived. Leakage shall be negligible!
- Related work primarily considers the binary output of PUFs, e.g. SRAM
 - Corresponding helper data related to Error-Correcting Code (ECC)
 - Many schemes available to choose from
 - Good results for key quality and reliability
 - Due to type of considered PUFs: no tamper-sensitivity

Related Work

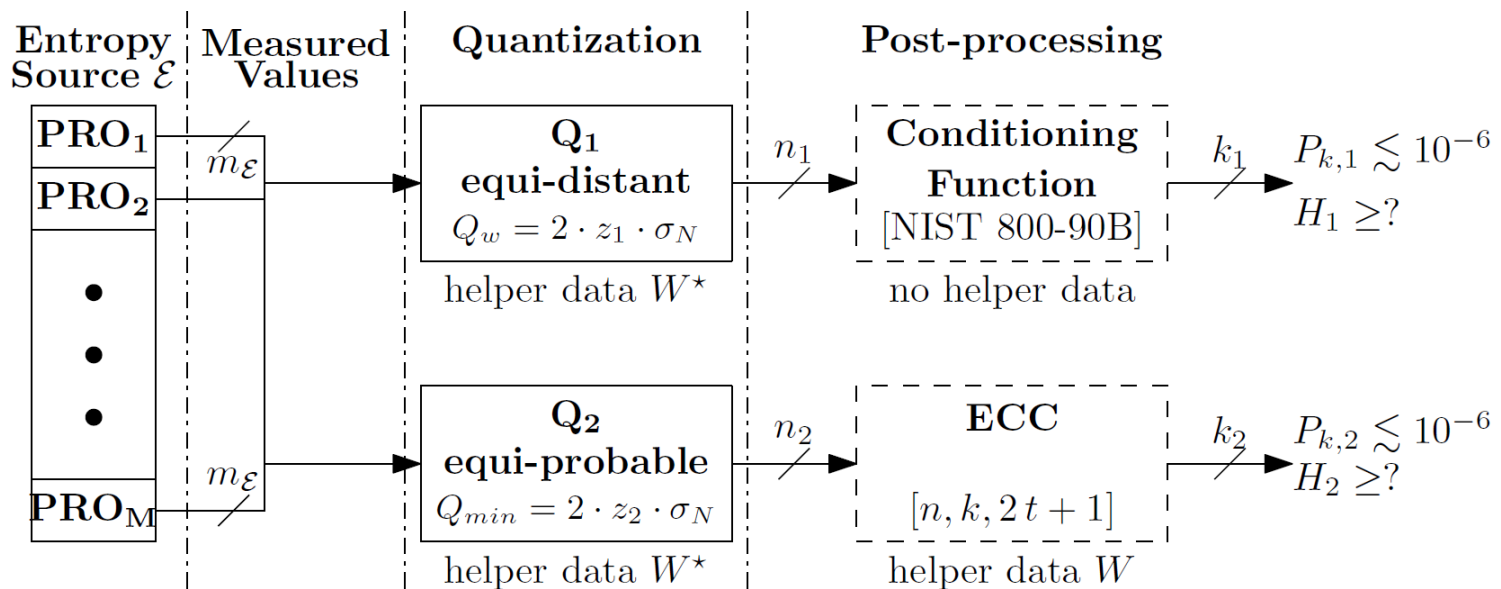
- Alternatives needed for the noisy m-bit (integer value) output of a POK
 - Pre-processing techniques to transform data (e.g., DCT)
 - Quantization
- Coating PUF (CHES 2006, Tuyls et. al.)
 - Random dielectric particles cover top of IC
 - Capacitive sensors measure capacitance
 - Key generation:
 - Measurement of capacitance
 - Equi-probable quantization of data
 - Additional Error-Correcting Code (ECC)



QUANTIZATION FOR POKS

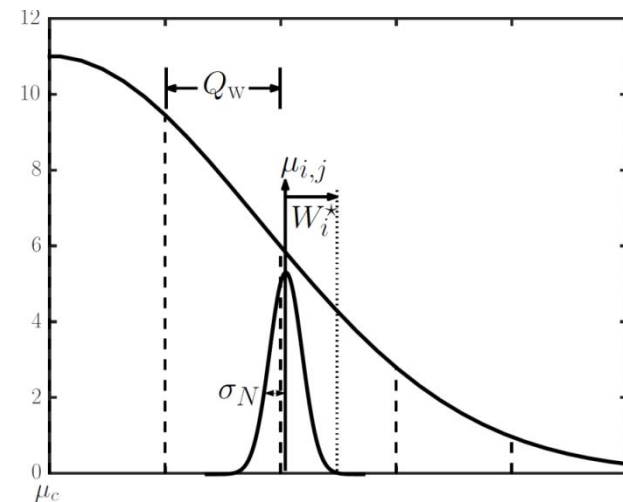
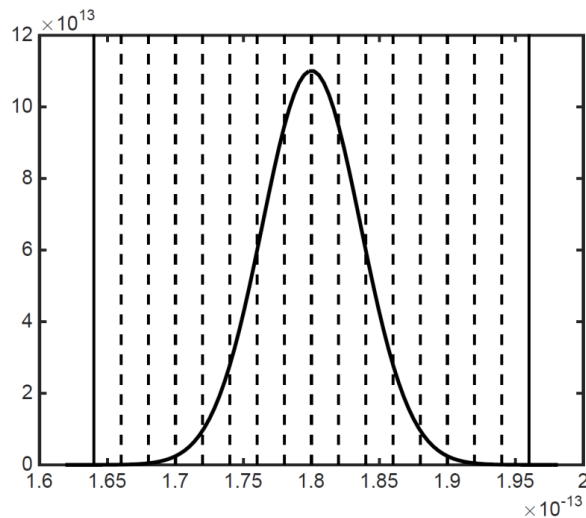
Quantization for POKs

- Analysis based on comparison of two different quantization strategies
 - Equi-distant quantization yields intervals with same width (Q1)
 - Equi-probable quantization yields equi-probable bits (Q2)
- Post-processing steps vary accordingly

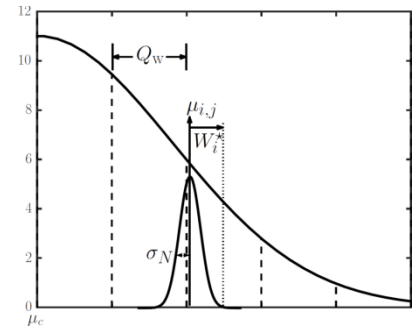
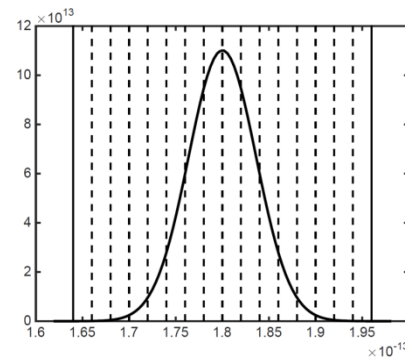


Equi-Distant Quantization

- Enrollment: Divide range of values in evenly spaced intervals
 - Measure POK-values multiple times and average to “remove” noise
 - Determine interval width and compute offset to middle of interval
- Reconstruction:
 - Measure POK-value once, apply offset and quantization



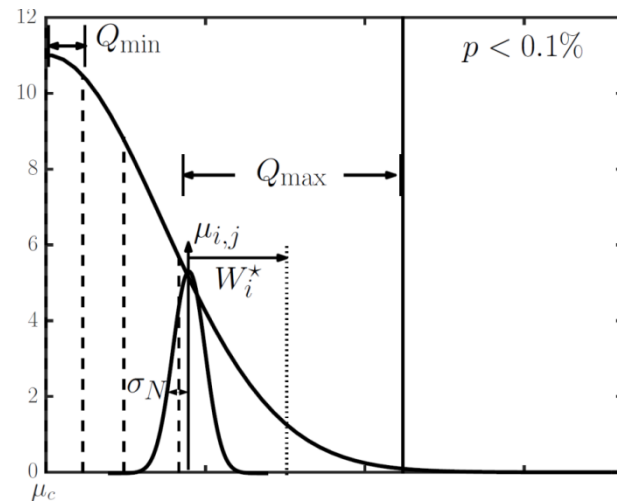
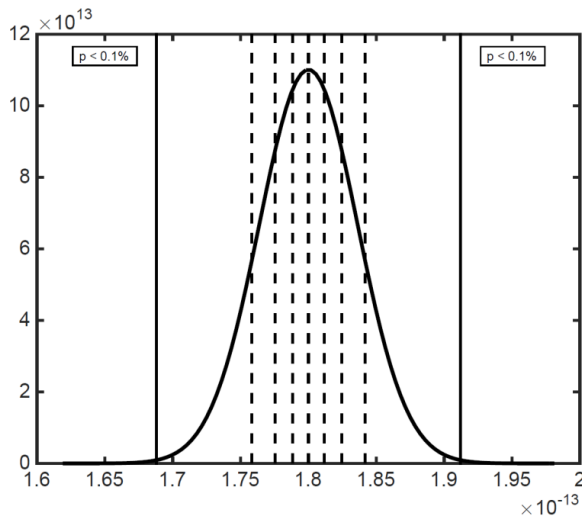
Equi-Distant Quantization



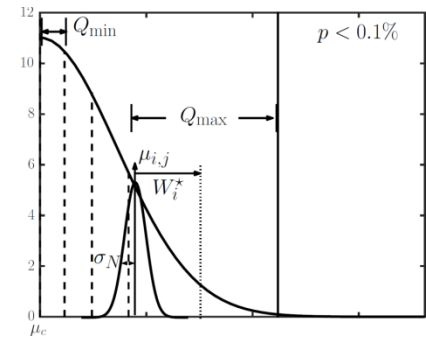
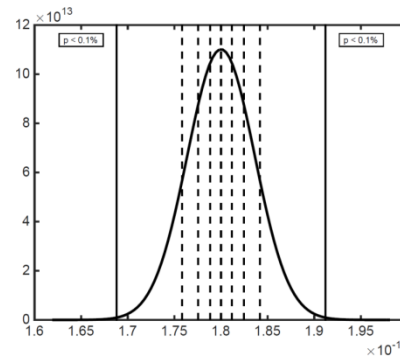
- Reliability:
 - Based on confidence interval $CI = [-z\sigma_N, z\sigma_N]$
 - Noise level must be determined (depends on device/application)
- Key quality:
 - Shannon entropy $H(F)$ depends on PDF and number of intervals L
 - Higher number of L causes $H(F)$ to approach the differential entropy
 - Resulting bits of quantization *not* equi-probable (requires hash)
- Considering possible attacks
 - $I(F, W^*)$: No information can be extracted
 - Tamper-sensitivity: Maximum shift for each interval is the same
- Limitations of this approach: Difficult to apply ECC

Equi-Probable Quantization

- Enrollment: Divide range of values in equi-probable intervals
 - Measure POK-values multiple times and average to “remove” noise
 - Determine interval width and compute offset to middle of interval
- Reconstruction:
 - Measure POK-value once, apply offset and do quantization



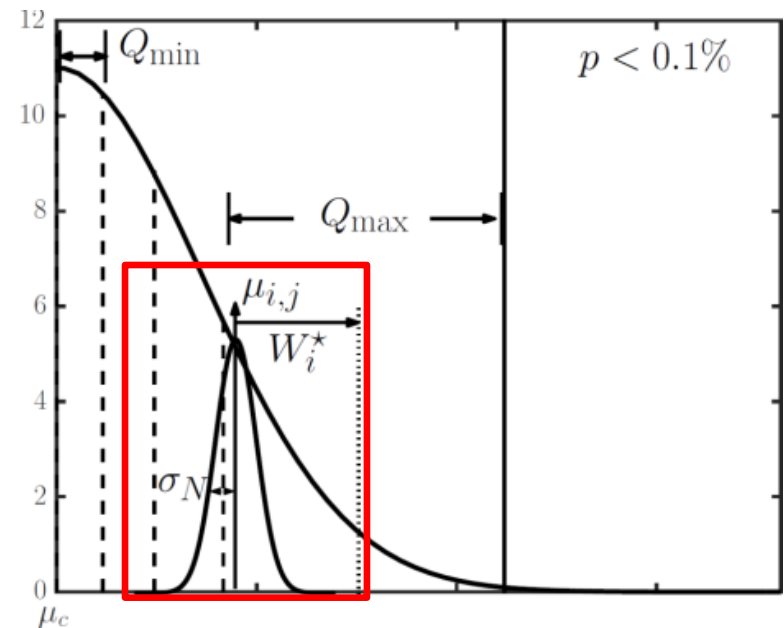
Equi-Probable Quantization



- Reliability:
 - Based on confidence interval of smallest interval
 - Noise level must be determined (depends on device/application)
- Key quality:
 - Shannon entropy $H(F)$ solely depends on number of intervals L
 - Resulting bits are already equi-probable
- Considering possible attacks
 - see next slides
- Limitations
 - see next slides

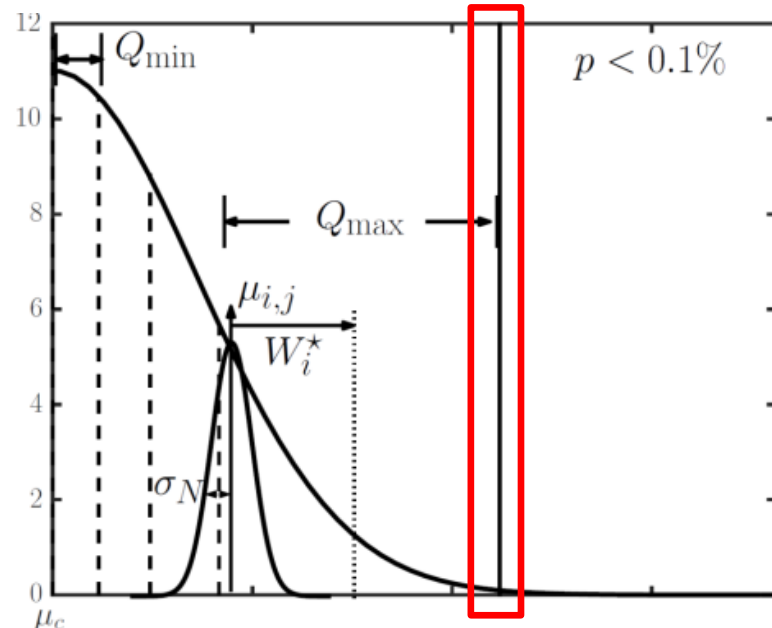
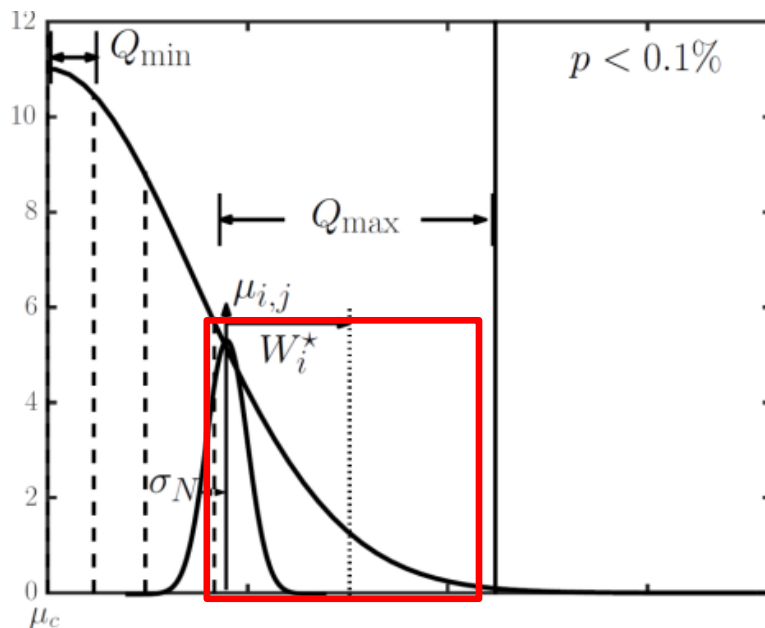
Equi-Probable Quantization: Weakness #1

- Observation:
 - Smallest interval: Q_{\min}
 - Largest interval: Q_{\max}
 - Offset W^* can exceed $Q_{\min}/2$
- $\rightarrow I(F, W^*)$ leaks information about F
- \rightarrow depending on value of W^* , helper data of quantization may fully determine quantized value of F
- *even worse:* for outermost interval, this value has highest probability to occur due to underlying PDF



Equi-Probable Quantization: Weakness #2

- Outermost intervals are less tamper-sensitive than innermost intervals
- Option 1: Valid range is limited by measurement range (bad)
- Option 2: Valid range is limited by boundary “guard” (better)

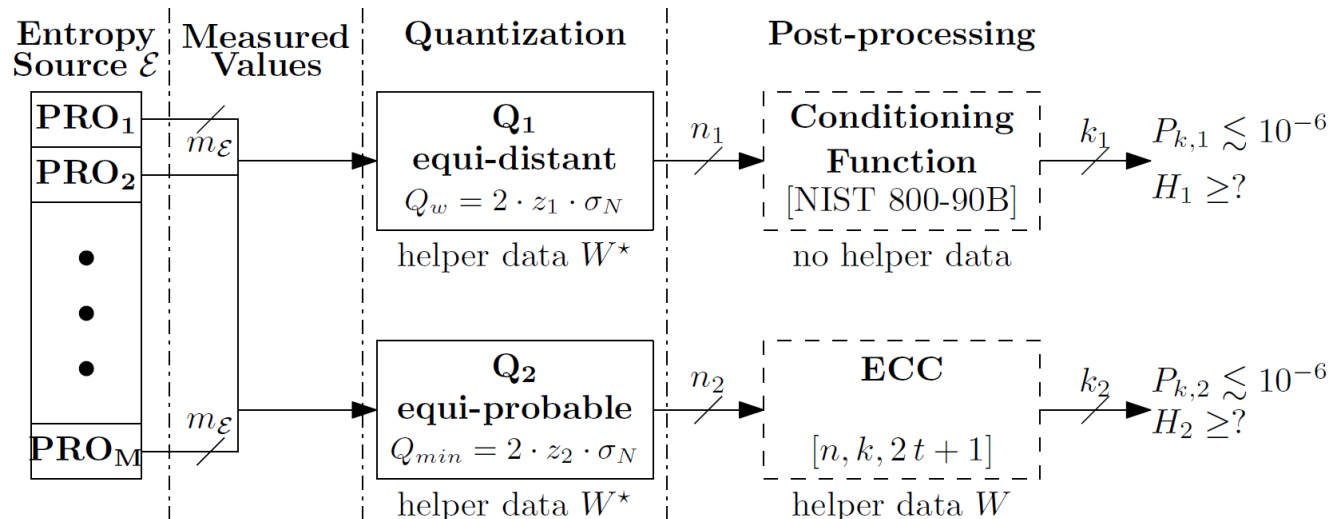


Can these Weaknesses be Mitigated?

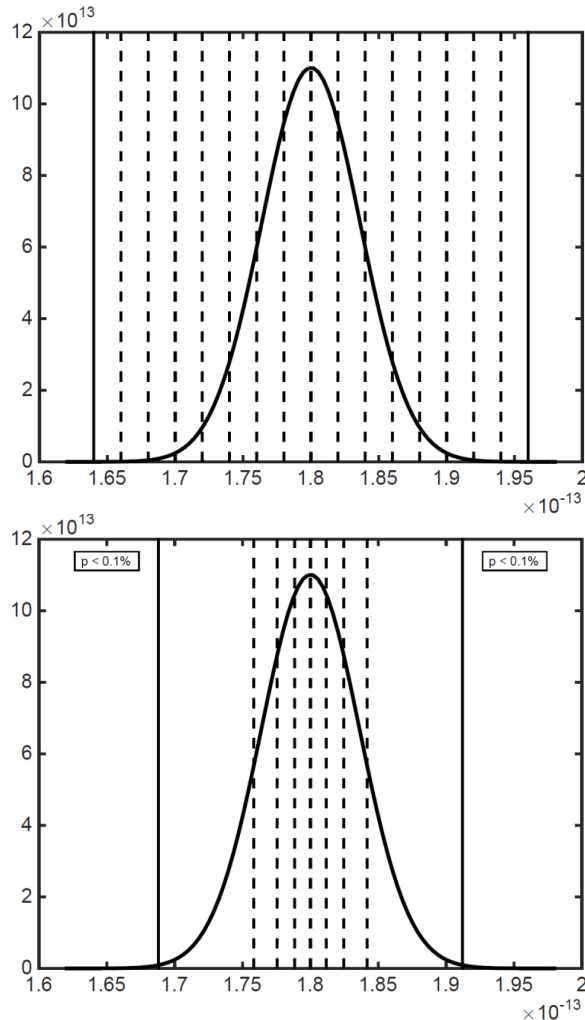
- Weakness: information leakage
 - One could limit range of W^* to $0.5 \cdot Q_{\min}$
 - Leakage is reduced but W^* is still biased
 - At the same time: maximum shift attacker can do increases
- Weakness: tamper-sensitivity
 - Outermost interval can be made smaller with guard / increases rejects
 - Still, outermost intervals will be less sensitive to attacks

Considered Parameters for the Key Generation

- Key mismatch probability, should be less than 10^{-6}
- $I(F, W^*)$ should be negligible
- Shannon entropy $H(F)$
- Worst-case shift by attacker not being detected (tamper-sensitivity)
- n bit (total number of bits extracted)
- k bit (key bits after all processing steps)



Analysis Results: Quantization Profiles (P1,P2,P3,P4)



P_1, Q_2 : Same approach as for the coating PUF in [10].

P_2, Q_2 : Modified approach of [10] to limit Q_{\max} .

P_3, Q_2 : The leakage of the helper data W^* is reduced.

P_4, Q_1 : The proposed equ-distant quantization.

Parameter	P_1	P_2	P_3	P_4
Quantizer	Q_2	Q_2	Q_2	Q_1
$P_k \lesssim 10^{-6}$	yes	yes	yes	yes
$I(F, W^*)$	leakage	leakage	reduced	negligible
$H(F)$ in bit	3	3	3	~ 2.9
$Q_{\min} [2\sigma_N]$	2.9	2.9	2.9	5.3
$Q_{\max} [2\sigma_N]$	inf	17.5	17.5	5.3
$W_{\text{worst}}^A [\sigma_N]$	inf	17.5	29.2	5.3
n bits	90	90	90	120
k bits ^a	66.4	66.4	66.4	60
t bits ^b	4	4	4	–

^aFor Q_2 , k is based on an optimal error correcting code [10], e.g., a code with parameters $[n, k, 2t + 1]$. For Q_1 , k is half the size of n due to requirements stated in NIST 800-90b.

^b t bits an error correcting code corrects. Considered as negative impact on tamper-sensitivity.

Implications

- Equi-probable quantization offers best worst-case sensitivity among all considered variants
- Equi-probable quantization should only be used if information leakage is reduced and boundary guard is used (P3)
- Side note: By using ECC one additionally corrects t bit

Parameter	P ₁	P ₂	P ₃	P ₄
Quantizer	Q_2	Q_2	Q_2	Q_1
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Conclusion

- Quantization is an important security aspect for POKs
- Any helper data should be considered for design (W and W^*)
- Tamper-sensitivity related to reliability...
 - ... but should be considered a metric on its own
 - ... not necessarily the same as influence by noise
- At stage of quantization:
 - Achieving equi-probability of bits difficult without major drawbacks
 - Additional processing required

Thank you very much for your attention!
Questions?